

US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

APPLICANT: MARTIN RICHARDSON

EUV, XUV, AND X-RAY WAVELENGTH SOURCES CREATED FROM LASER PLASMA

PRODUCED FROM LIQUID METAL SOLUTIONS

LIST OF ART CITED BY APPLICANT

U.S. PATENT DOCUMENTS

CT AA 4,024,400 05/17/77 Blyras et al. 250 432 05/13/76 AB 4,328,464 05/04/82 Pivirotto 330 4.3 02/07/80 AC 4,700,371 10/13/87 Forsyth et al. 378 34 11/08/84 AD 4,723,262 02/02/88 Noda et al. 378 119 12/26/85 AE 4,866,517 09/12/89 Mochizuke et al. 378 119 09/10/87 AF 4,953,191 08/28/90 Smither et al. 378 143 07/24/89 AG 5,126,755 06/30/92 Sharpe et al. 346 75 03/26/91 AH 5,142,297 08/25/92 Eijkman et al. 346 1.1 03/26/90 AI 5,148,462 09/15/92 Spitsyn et al. 378 143 04/08/91 AJ 5,151,928 09/29/92 Hirose 378 119 08/20/91 AK 5,243,638 09/07/93 Wang et al. 378 119 03/10/92 AL 5,257,303 10/26/93 Das Gupta 378 85 08/03/92 AM 5,459,771 10/17/95 Richardson et al. 378 119 04/01/94 AN 5,577,091 11/19/96 Richardson et al. 378 119 01/13/95 AO 5,577,092 11/19/96 Kublak et al. 378 119 01/13/95 AP 5,991,360 11/23/99 Matsui et al. 378 119 01/21/98		EXAMINER	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
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